Search Notes



App	lica	tion	Contr	ol No
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Reexamination

Applicant(s)/Patent Under

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Examiner

Art Unit

MATTHEW G KAYRISH

2627

SEARCHED

Class	Subclass	Date	Examiner
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369	59.21, 47.22,	7/28/2008	MGK
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SEARCH NOTES

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EAST (Search History Attached)	7/28/2008	MGK
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INTERFERENCE SEARCH

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